Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/672,151	JACOBS ET AL.	
Examiner	Art Unit	_
Binh X. Tran	1765	

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Class	Subclass	Date	Examiner
438	710	4/28/2005	BT
438	712	4/28/2005	3
438	714	4/28/2005	37
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